

Search Notes



Application/Control No.

10/619,861

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

PETRICK ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	50.01 50.02 64		
312	223.6 196		
	195		
	223.3		
52	36.1		
	206.7		
	220.9		

INTERFERENCE SEARCHED

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
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